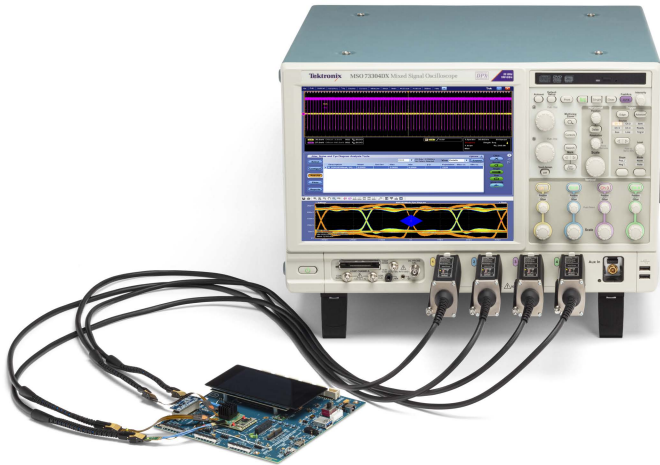


DDR5 Memory Interface Electrical Verification and Debug Opt. DDR5SYS and 7-CMDDR5SYS – System Level Transmitter Tests Datasheet



DDR (Dual Data Rate) is a dominant and fast-growing memory technology. It offers high data transfer rates required for computing applications, from consumer products to the most powerful servers. The high speed of these signals requires high-performance measurement tools. Tektronix TekExpress DDR Tx is an automated test application used to validate and debug the DDR5 designs of the DUT as per the JEDEC specifications. The solution enables you to achieve new levels of productivity, efficiency, and measurement reliability.

Key features

- Supports 86 measurements of DDR5 System Transmitter Tests as per DDR5 JEDEC specification:
 - 26 Clock Differential measurements
 - 21 Clock Single Ended measurements
 - 13 Write Burst Differential measurements
 - 1 Write Burst Single Ended measurements
 - 17 Read Burst differential measurements
 - 8 Address Command measurements
- User-Defined Acquisition (UDA) mode for Clock, Write Clock, CA, CS, Data Strobe, and data for both Write and Read traffic (or bursts).

UDA: TekExpress DDR Tx for DDR5 Transmitter Solution puts control back where it should be, with the user. User defined acquisition mode allows you to run DDR5 JEDEC compliance measurements by customizing scope settings like sample rate, record length, bandwidth, and more.
- De-embedding support for Clock, Command Address, Data Strobe, and data for both Write and Read traffic (or bursts)
- Number of UIs support for Clock and Read/Write data measurements
- Deploys DDR DFE standalone application, that can be launched from TekScope > Analyze > DDR DFE¹

- Support DFE for Write Data Eye measurements¹
- Multi-Run feature is applicable for all tests
- Save worst case waveform in known/TekExpress sessions
- Retain Vertical Scale settings supported during acquisition
- User-friendly measurement configurations
- Test report to reflect all the statistics of the measurement
- User can select the source and the channel in the acquisition panel
- Multiple Burst Detection Method supported:
 - Read and Write
 - Write Only
 - Read Only
 - Visual Search¹
- Diamond shape mask and margin analysis for Write Data Eye measurement
- Custom Data Rate support upto 15000MT/s
- Noise Compensation support for Clock measurements¹

Applications

Tektronix provides the most comprehensive solution to serve the needs of the engineers designing DDR silicon for server, computer, graphics systems, mobile, embedded systems, and for those who are validating the physical-layer compliance of DDR Memory Compliance Test Specification.

The Tektronix option DDR5SYS (TekExpress DDR Tx) includes compliance and debug solution for the following:

- DRAM components
- Data Buffer/RCD components
- System boards
- Embedded systems
- Servers and Client/Desktop

The Tektronix option DDR5SYS is compatible with the following Tektronix oscilloscope models:

- 7 Series scope, model DPO714AX at 16 GHz, 20 GHz, and 25 GHz
- MSO71604DX, MSO72004DX, MSO72304DX, MSO72504DX, and MSO73304DX
- DPO73304DX
- Non-ATI channels of DPO75002SX, DPO75902SX, DPO7702SX, DPS75004SX, DPS75904SX, DPS77004SX and DPO73304SX

The above mentioned Tektronix oscilloscopes are designed to meet the challenges of the next generation memory standards and provide the industry's

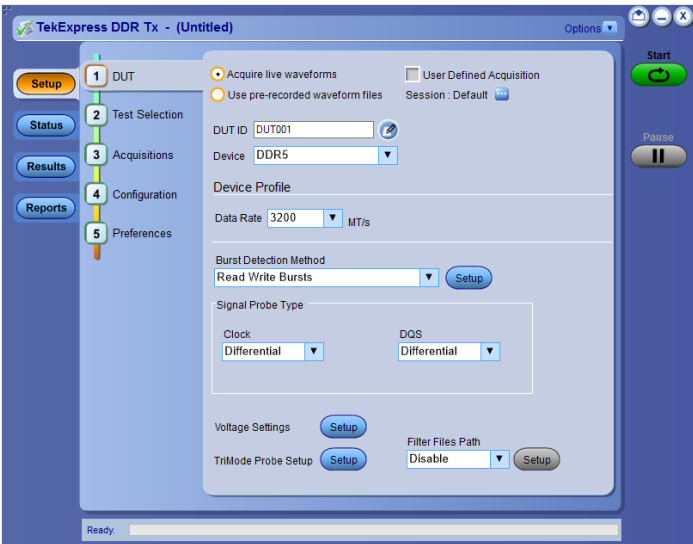
¹ This feature is supported only for MSO/DPO70000 SX/DX oscilloscope models (Opt. DDR5SYS)

leading vertical noise performance with the highest number of effective bits (ENOB) and flattest frequency response for oscilloscopes in their class.

DDR5 system level tests

The Tektronix TekExpress DDR Tx solution reduces the effort and accelerates the compliance testing for DDR systems and devices with several unique and innovative capabilities.

The TekExpress DDR Tx application provides a simple, step-by-step, and easy-to-use interface to speed up the testing process. User can select the memory technology of interest in Device, Data Rate, Burst Detection Method, select the probing configuration used for Clock, and strobe in the Setup DUT panel, in the next step perform the test selection as per measurement group (Clock, Command Address, Data Strobe, and Data for both Read and Write traffic (or bursts)) and individual measurements within the group provide different methods of Burst detection.



TekExpress DDR Tx – application launch screen

The TekExpress DDR Tx application comes with a unique feature to select or deselect the signal. Once the signal is selected in the acquisition panel, the user can select the signal source connected to the oscilloscope.



Acquisition panel – signal source selection

De-embed filters

Easily de-embed the interposer and the probe effects by applying suitable de-embed filters within the DDR5 standard.



De-embed filters

Comprehensive measurements

The option DDR5SYS and 7-CMDDR5SYS adds a long list of JEDEC specific measurements for DDR5 memory standards. The TekExpress DDR Tx application covers Electrical measurements, Timing measurements, and Eye Diagram measurements as per the JEDEC standards.

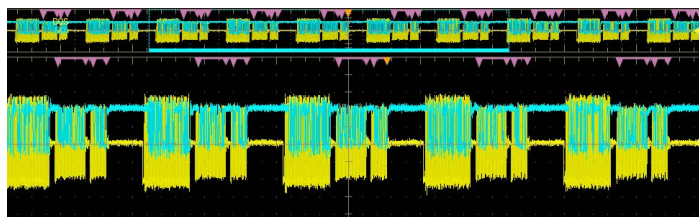
Automated Read and Write Burst detection

The TekExpress DDR Tx provides different ways to detect the burst cycles that are used to perform measurements:

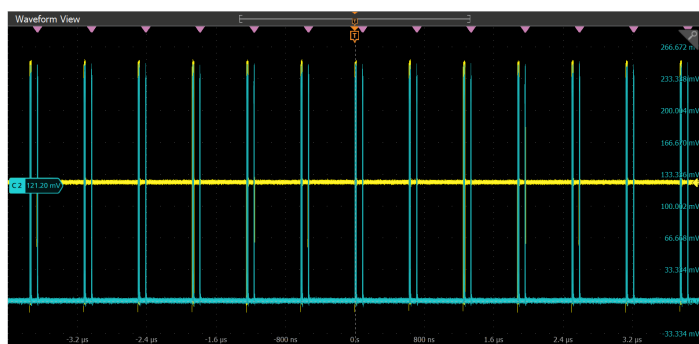
- Read Write Bursts – when the DUT traffic is configured to send both Read and Write bursts then this method is used for burst detection.
- Write Only – when the DUT traffic is configured to send all Write Bursts then this method is used for burst detection.
- Read Only – when the DUT traffic is configured to send all Read Bursts then this method is used for burst detection.
- Visual Search¹ – defining Visual Trigger areas to identify and gate area of interest for measurements

Burst Detection Method
Read Write Bursts
Read Write Bursts
Write Only Bursts
Read Only Bursts
Visual Search

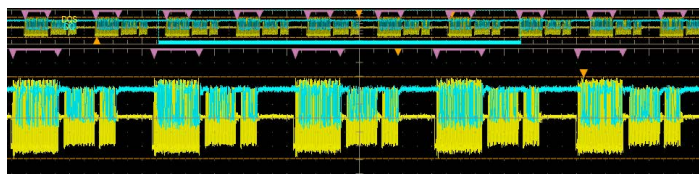
Burst detection



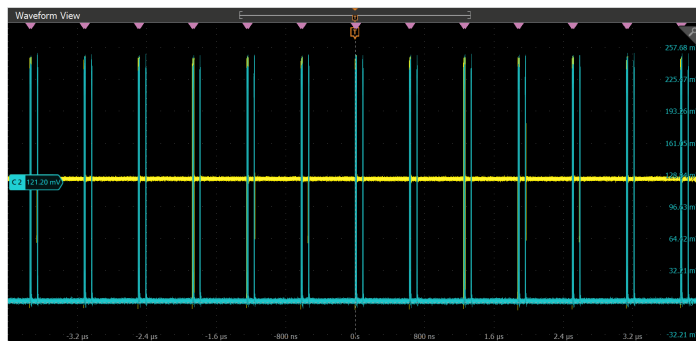
Automated Read and Write Burst detection – for Write Bursts on MSO/DPO70000 Series



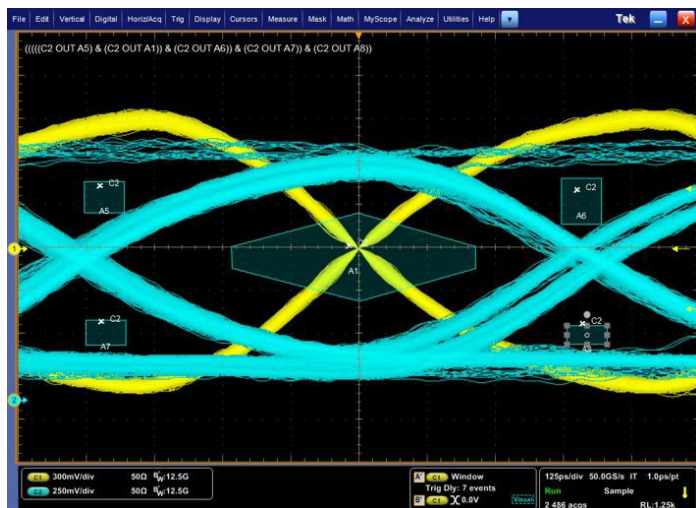
Write burst detection on 7 Series scope, model DPO714AX



Automated Read and Write Burst detection – for Read Bursts on MSO/DPO70000 Series



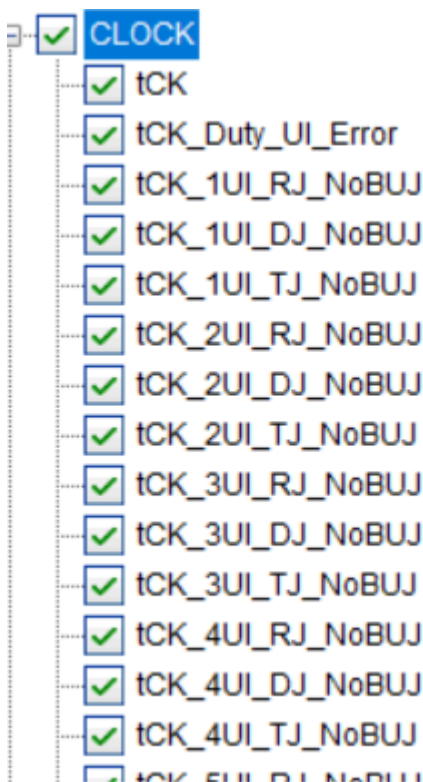
Read burst detection on 7 Series scope, model DPO714AX



Visual trigger

Test selection

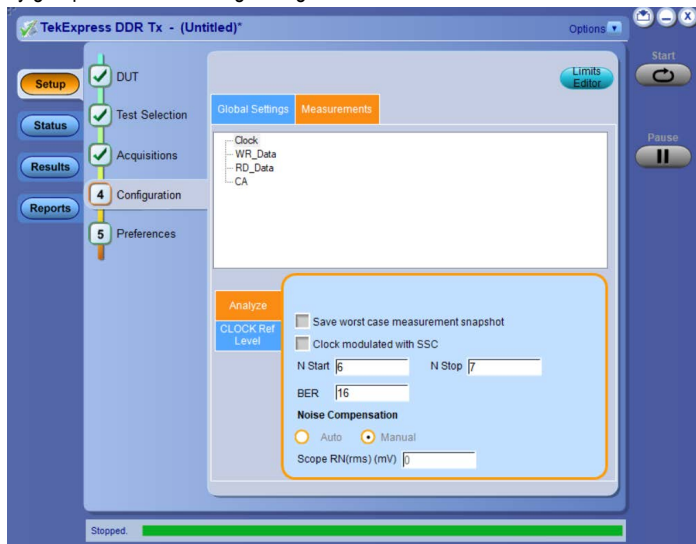
The TekExpress DDR Tx test selection panel allows the user to select the various measurements supported by the application.



Test selection panel – tree view of measurements

Configurations

Ease of use measurement configuration to configure measurements by group instead of running through all the 50+ measurements.

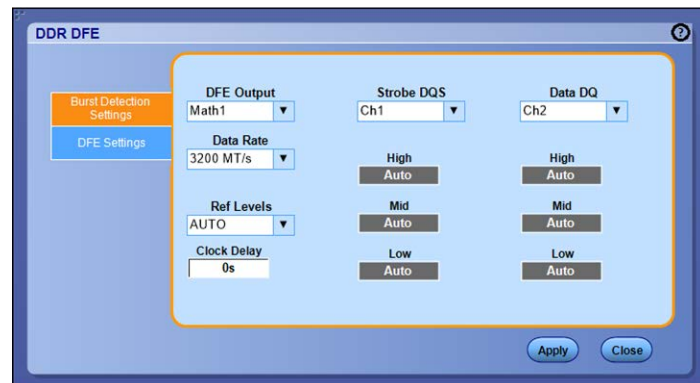


DDR DFE standalone plugin¹

The DDR5 application supports data rates from 3200 MT/s to 8400 MT/s on DPO/MSO70000 DX/SX oscilloscopes. This increase in the data rate is realized without the need for differential signaling at the DQ pins i.e. the DQ bus is single-ended – same as DDR3/4. However, due to the many impedance

mismatched points that exist along with the memory subsystem, ISI due to reflections are expected to increase. At data rates $\geq$ to 4800 MT/s, the data eye at the DRAM ball is expected to be closed. A 4-tap DFE is implemented in the DDR5 DRAM Rx to help equalize the DQ signals and open the data eyes after the data is latched by the receiver.

The TekExpress DDR Tx application provides DDR DFE as a standalone software application in Tektronix's performance scopes. It is used to perform 4 tap DFE operation on the DDR5 write burst signals coming from the DDR5 DUTs.

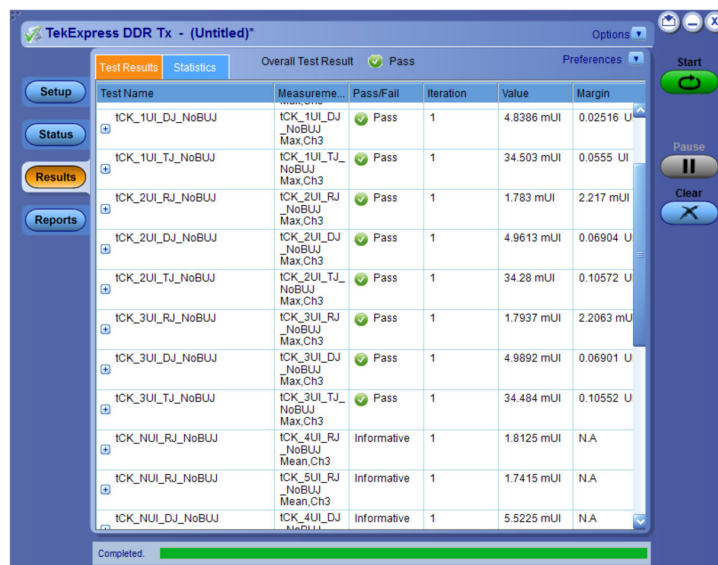


DDR DFE standalone plugin

Results and reporting with waveform

The measurement configurations and JEDEC pass/fail limits are automatically applied for the selected measurements based on the memory specification and the selected speed grade. The results report includes DDR measurements statistical data, measurement plots, and the screenshot of the waveforms with the cursors. Hyperlinks within the report allows you to navigate between the sections.

When test execution is complete, the application automatically opens the Results panel and displays the summary of test results.



Measurement results

Tektronix®		TekExpress DDR Tx Transmitter Test Report	
Device Information			
QST ID	QST001	Scope Model Number	QST011AAN
Date/Time	8/18/2025 12:12:22 AM	Scope Serial Number	QK001009
Device Type	Q045	SAR, Factory Calibration	NA000001
Firmware Version	Firmware: 5.1.3.2.0.4	Scope I/FM Version	5.21.31.117.2.0.0.1-release.0086
App Version	QST-TE 1.0.0.0	Click Signal Probing	Differential
QST User Revision	QST01-PC-02-01-V1.01	QST Signal Probing	Differential
QST Signal	Line	QST Rate	3200 Mtx/s
User Defined Acquisition	Disabled	Bandwidth	20 GHz
Overall Execution Time	00:00:00		
Overall Test Result	Fail		

Probe Information			
Source	Signal	Probe Type	Probe Serial Number
EW1	DQS	"TCA292B"	"N/A"
EW2	DQ	"TCA292B"	"N/A"
EW3	Clock	"TCA292B"	"N/A"
EW4	FA	"TCA292B"	"N/A"

[illegible]

Measurement report

Verification versus debug

The TekExpress DDR Tx application provides a comprehensive set of JEDEC timing and electrical measurements for the DDR5 standard. Also, it provides access to the DPOJET advanced Jitter and Timing analysis engine that allows flexibility to reconfigure the existing measurements or to perform new measurements that are not defined by the JEDEC specification using new user-specified test limits. Additionally, it features logging, filters, histograms, and time trends that are available in DPOJET. The user can also switch between debug mode and the compliance mode.

Oscilloscope triggering and waveform identification

The Tektronix Pinpoint® trigger system provides the most comprehensive high-performance trigger system in the industry. The Pinpoint trigger system encompasses threshold and timing related triggers, Dual A and B Event Triggering, Logic Qualification, Window Triggering, and Reset Triggering.

The Advanced Search and Mark feature in the Tektronix MSO/DPO5000, DPO7000, MSO/DPO70000 series and 7 Series DPO oscilloscopes find unique events in the waveforms. It scans acquired waveform data for multiple occurrences of an event and marks each occurrence.

The Search and Mark feature has a close relationship with the Pinpoint trigger system since they both can be used to discriminate signal characteristics. Search and Mark includes signal-shape discrimination features of the Pinpoint trigger system and extends them across live channels, stored data, and math waveforms.

The Visual Trigger makes the identification of the desired waveform events quick and easy by scanning all the acquired analog waveforms and comparing them with the geometric shapes on the display. By discarding the acquired waveforms which do not meet the graphical definition, Visual Triggering extends the oscilloscope's trigger capabilities beyond the traditional hardware trigger system. This feature is currently supported only on MSO/DPO70000 SX/DX oscilloscope models.

Specifications

Supported oscilloscopes

- 7 Series scope, model DPO714AX at 16 GHz, 20 GHz, and 25 GHz
- MSO71604DX, MSO72004DX, MSO72304DX, MSO72504DX, and MSO73304DX
- DPO73304DX
- Non-ATI channels of DPO75002SX, DPO75902SX, DPO7702SX, DPS75004SX, DPS75904SX, DPS77004SX and DPO73304SX

Data rate	Minimum bandwidth	Channels	Description
Up to 8800 MT/s	16 GHz	4	• 7 Series scope, model DPO714AX • MSO71604DX

Recommended probes

Active probes	Description
P7720	20 GHz TriMode probe with TekFlex connector technology
P7716	16 GHz TriMode probe with TekFlex connector technology

Probe tips	Description
P77STFLXA/P77STCABL	Active, Solder-in Tip with TekFlex connector technology, probe tips to probe directly on the motherboard/vias or interposers with 0 Ω resistor.
P77STFLXB/P77STLRCB	Active, Solder-in Tip with TekFlex connector technology, probe tips to probe on the SI Interposer with 100 Ω resistor (Nexus XH Series Interposer).
P77STFLRA	Active, long reach solder-in tip with TekFlex connector technology
P77HTFLRA	Active, long reach high temperature solder-in tip with TekFlex connector technology
P77STFLRB	Active, long reach 55 Ω Solder-in tip with TekFlex Connector technology for DDR/LPDDR electrical Validation with interposers
P77HTFLRB	Active, long reach 55 Ω Solder in tip with TekFlex Connector technology for high-temperature DDR/LPDDR electrical Validation with interposers (up to 125 °C)
SI Interposer	EdgeProbe™, Direct Attach, and Socketed Interposer are available from Nexus. Order directly from Nexus. Request the s-par files for all individual signals on the interposer instead of getting a generic nominal s-par model. Refer the Nexus's page for more information: www.nexustechology.com/products/memory-interposers/ddr5-main-memory-interposers/

Ordering information

To order on 7 Series scope, model DP0714AX

Nomenclature	Description
7 Series DPO >= 16 GHz	
7-CMDDR5SYS	License; DDR5 System Transmitter Test (Tx) Automated Compliance Solution using TekExpress Framework; Canned, Electronically Downloaded; Requires options 7-DJA, 7-SIMA and 7-WIN; Node Locked
7-CMDDR5SYS-FL	License; DDR5 System Transmitter Test (Tx) Automated Compliance Solution using TekExpress Framework; Canned, Electronically Downloaded; Requires options 7-DJA, 7-SIMA and 7-WIN; Floating

To order on DPO/MS070000 Series:

Nomenclature	Description
SX, DX >= 16 GHz	
DPO-UP DDR5SYS	License: DDR5 TekExpress Compliance/Debug Automation Memory Bus Electrical Validation and Analysis Software (require options SDLA64, DJA, and VET)
DPO73304DX DDR5SYS	License: DDR5 TekExpress Compliance/Debug Automation Memory Bus Electrical Validation and Analysis Software (require options SDLA64, DJA, and VET)
DPO73304SX DDR5SYS	License: DDR5 TekExpress Compliance/Debug Automation Memory Bus Electrical Validation and Analysis Software (require options SDLA64, DJA, and VET)
DPO75002SX DDR5SYS	License: DDR5 TekExpress Compliance/Debug Automation Memory Bus Electrical Validation and Analysis Software (require options SDLA64, DJA, and VET)
DPO75902SX DDR5SYS	License: DDR5 TekExpress Compliance/Debug Automation Memory Bus Electrical Validation and Analysis Software (require options SDLA64, DJA, and VET)
DPO7702SX DDR5SYS	License: DDR5 TekExpress Compliance/Debug Automation Memory Bus Electrical Validation and Analysis Software (require options SDLA64, DJA, and VET)
MSO71604DX DDR5SYS	License: DDR5 TekExpress Compliance/Debug Automation Memory Bus Electrical Validation and Analysis Software (require options SDLA64, DJA, and VET)
MSO72004DX DDR5SYS	License: DDR5 TekExpress Compliance/Debug Automation Memory Bus Electrical Validation and Analysis Software (require options SDLA64, DJA, and VET)
MSO72304DX DDR5SYS	License: DDR5 TekExpress Compliance/Debug Automation Memory Bus Electrical Validation and Analysis Software (require options SDLA64, DJA, and VET)
MSO72504DX DDR5SYS	License: DDR5 TekExpress Compliance/Debug Automation Memory Bus Electrical Validation and Analysis Software (require options SDLA64, DJA, and VET)
MSO73304DX DDR5SYS	License: DDR5 TekExpress Compliance/Debug Automation Memory Bus Electrical Validation and Analysis Software (require options SDLA64, DJA, and VET)
DPS75004SX DDR5SYS	License: DDR5 TekExpress Compliance/Debug Automation Memory Bus Electrical Validation and Analysis Software (require options SDLA64, DJA, and VET)
DPS75904SX DDR5SYS	License: DDR5 TekExpress Compliance/Debug Automation Memory Bus Electrical Validation and Analysis Software (require options SDLA64, DJA, and VET)
DPS77004SX DDR5SYS	License: DDR5 TekExpress Compliance/Debug Automation Memory Bus Electrical Validation and Analysis Software (require options SDLA64, DJA, and VET)

To order floating licenses on existing DPO/MS070000 Series:

Product Nomenclature	Description	Mapped Options	Required Options
DPOFL-DDR5SYS	License; DDR5 System-level Tx TekExpress Compliance/Debug Automation Software; Floating	DDR5SYS	SDLA64, DJA, and VET

Table continued...

Product Nomenclature	Description	Mapped Options	Required Options
DPOFT-DDR5SYS	License; DDR5 System-level Tx TekExpress Compliance/Debug Automation Software; Floating Trial	DDR5SYS	SDLA64, DJA, and VET

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Product(s) complies with IEEE Standard 488.1-1987, RS-232-C, and with Tektronix Standard Codes and Formats.

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